

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/589,544 CHANG ET AL.	
		Examiner	Art Unit Qiuwen Mi	1655 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0208863	10-2004	Versalovic et al.	424/115
*	B	US-2005/0180962	08-2005	Raz et al.	424/093.45
*	C	US-1,459,395	06-1923	TONI HAMBURGER	435/139
	D	US-			
	E	US-			
	E	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000236873	01-1999	Japan	-----	-----
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.